

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES
PAGE : 1/11

Index

1. Scope
2. Part name & part number
3. Construction、 dimensions、 material & surface finish
4. Characteristics
5. Conditions
6. Mechanical test
 - 6.1 Crimp width、 crimp height & crimp strength
 - 6.2 Insertion force & withdrawal force
 - 6.3 Crimp Tensile Strength
 - 6.4 Contact retention force
 - 6.5 Post retention force
7. Electrical test
 - 7.1 Contact resistance
 - 7.2 Insulation resistance
 - 7.3 Dielectric withstanding voltage
8. Environmental test
 - 8.1 Repeated Insertion/Withdrawal
 - 8.2 Humidity
 - 8.3 Salt spray
 - 8.4 Heat Resistance & Cold Resistance
 - 8.5 Thermal shock
 - 8.6 Vibration
 - 8.7 Solderability
 - 8.8 Resistance to soldering heat

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PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 2/11

1.SCOPE:

This specification covers the requirements for product performance of 1.50mm pitch wire to board connector series.

2.PART NAME & PART NUMBER:

Part Name	Part Number
Housing	A1501HD
Terminal	A1501-T-D
Wafer	A1501WRD-S A1501WVD-S

3.CONSTRUCTION、 DIMENSIONS、 MATERIAL & SURFACE FINISH:

Construction and dimensions shall be in accordance with the referenced drawings.

Material and surface finish shall be as specified below.

Part Name	Material		Surface finish
Housing	PBT		UL94V-0
Terminal	Phosphor Bronze		Surface finish
Wafer	Body	LCP	UL94V-0
	Pin	Phosphor Bronze	Tin over Nickel
	Solder Tabs	Phosphor Bronze	Tin over Nickel

4. CHARACTERISTICS:

Current rating: 2A AC,DC

Voltage rating: 100V AC,DC

Temperature range: -40°C ~ 105°C

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 3/11

5. CONDITIONS:

The conditions shall be in accordance with the referenced data of next table.

Number	Item	Requirement
①	Bend up	4°max.
	Bend down	4°max.
	Twisting	3°max.
	Rolling	8°max.
②	Bell mouth (flare)	0.2-0.5 mm
③	Cut-off tab length	0.2 mm max.
④	Extruded wire length	0-0.5 mm
⑤	Seam	Seam shall not be opened and no wire allowed out of
⑥	Wire strip length	1.2-1.7 mm ref.
⑦	Lance height	0.3 mm ref.

6. MECHANICAL TEST

6.1 Crimp width、crimp height & crimp strength

After crimping, the crimped areas [(5)、(6)] should be as follows.

Wire Size (AWG)	Terminal Part Number	Conductor(mm)		Insulation(mm)		Crimp Strength (Kg)
		Crimp Width	Crimp Height	Crimp Width	Crimp Height	
# 24	A1501-T-D	0.9±0.15	0.62-0.67	1.10 (max)	1.35(max)	3.00(min)
# 26			0.57-0.62		1.25(max)	2.00(min)
# 28			0.50-0.55		1.20(max)	1.00(min)

Note: no distorted after terminal crimped.

6.2 INSERTION FORCE (I.F.) & WITHDRAWAL FORCE (W.F.)

(1) Requirement: (unit : kgf)

N=10

Number of Circuits	At initial		At 30th	Locking Strength(Min)
	I.F. (max)	W.F. (min)	W.F. (min)	
Single	0.55	0.035	0.035	0.50
2	1.10	0.070	0.070	1.00
3	1.65	0.105	0.105	1.50

PRODUCT SPECIFICATION

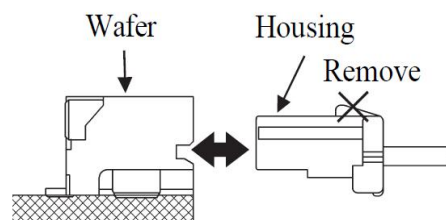
PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 4/11

4	2.20	0.140	0.140	2.00
5	2.75	0.175	0.175	2.50
6	3.30	0.210	0.210	3.00
7	3.85	0.245	0.245	3.50
8	4.40	0.280	0.280	4.00
9	4.95	0.315	0.315	4.50
10	5.50	0.350	0.350	5.00
11	6.05	0.385	0.385	5.50
12	6.60	0.420	0.420	6.00
13	7.15	0.455	0.455	6.50
14	7.70	0.490	0.490	7.00
15	8.25	0.525	0.525	7.50
16	8.80	0.560	0.560	8.00

(2) Test method: Housing with crimped terminal and wafer shall be mated and unmated on the same axis. Initial insertion and withdrawal forces and withdrawal forces at 30th shall be measured for single circuit and multi-circuits. For the measurement of single circuit , housing lock shall be removed.

Insertion and withdrawal speed: 25.4 mm/minute.



(3) Test results: (unit : kgf)

N=10

Number of Circuits		At initial		At 30th	Locking Strength
		I.F.(kg)	W.F.(kg)	W.F. (kg)	
Single	Max.	0.25	0.20	0.21	1.10
	Min.	0.18	0.14	0.17	0.75
	Ave.	0.22	0.18	0.19	0.85
2	Max.	0.49	0.39	0.41	2.08
	Min.	0.37	0.27	0.35	1.42
	Ave.	0.43	0.35	0.38	1.65

PRODUCT SPECIFICATION
PRODUCT SERIES NAME: A1501-D SERIES
PAGE : 5/11

3	Max.	0.73	0.59	0.62	3.13
	Min.	0.56	0.41	0.52	2.35
	Ave.	0.65	0.53	0.57	2.68
4	Max.	0.97	0.79	0.83	4.21
	Min.	0.75	0.55	0.69	2.89
	Ave.	0.87	0.71	0.76	3.60
5	Max.	1.22	0.98	1.03	5.33
	Min.	0.93	0.68	0.87	3.70
	Ave.	1.08	0.88	0.95	4.46
6	Max.	1.45	1.20	1.28	6.36
	Min.	1.08	0.90	0.98	4.37
	Ave.	1.25	1.08	1.12	5.28
7	Max.	1.69	1.41	1.49	7.50
	Min.	1.26	1.06	1.15	5.12
	Ave.	1.46	1.27	1.31	6.13
8	Max.	1.93	1.61	1.70	8.65
	Min.	1.44	1.21	1.32	5.98
	Ave.	1.67	1.45	1.50	6.82
9	Max.	2.17	1.82	1.92	9.74
	Min.	1.62	1.36	1.45	6.32
	Ave.	1.88	1.63	1.69	7.62
10	Max.	2.42	2.03	2.12	10.45
	Min.	1.81	1.50	1.60	6.86
	Ave.	2.11	1.81	1.87	8.24
11	Max.	2.62	2.23	2.32	11.12
	Min.	1.98	1.65	1.70	7.35
	Ave.	2.32	1.99	2.05	8.92
12	Max.	2.91	2.45	2.55	11.83
	Min.	2.16	1.76	1.90	7.89
	Ave.	2.53	2.15	2.23	9.53
13	Max.	3.15	2.64	2.76	12.56
	Min.	2.30	1.90	2.00	8.43
	Ave.	2.74	2.52	2.42	10.12
14	Max.	3.39	2.87	2.97	13.21
	Min.	2.52	2.12	2.11	8.92
	Ave.	2.95	2.72	2.62	10.80
15	Max.	3.63	3.05	3.18	13.82
	Min.	2.73	2.25	2.55	9.48
	Ave.	3.16	2.72	3.08	10.76
16	Max.	3.87	3.25	3.39	14.46
	Min.	2.90	2.42	2.56	9.95
	Ave.	3.38	2.90	2.95	11.38

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 6/11

6.3 CRIMP TENSILE STRENGTH

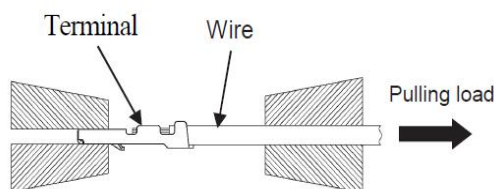
(1) Requirement & Test results: (unit : kgf) N=10

Wire Size (AWG)	Requirements (min)	Max	Min	Ave.
#24	3.00	5.10	6.10	5.53
#26	2.00	3.99	3.20	3.63
#28	1.00	2.55	2.15	2.32

(2) Test method: Crimped terminal shall be mounted in a housing and pulled in an alignment.

The load to pull the terminal out of the housing shall be measured.

Insertion and withdrawal speed: 25.4 mm/minute.



6.4 CONTACT RETENTION FORCE

(1) Requirement: 1.0 kgf (min.)

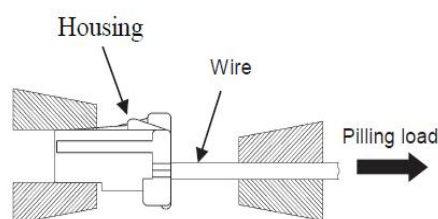
(2) Test method: Crimped terminal shall be mounted in a housing and pulled in an alignment.

The load to pull the terminal out of the housing shall be measured.

Insertion and withdrawal speed: 25.4 mm/minute

(3) Test results: N=10

Max.	Min.	Ave.
1.84kgf	1.32kgf	1.60kgf



6.5 POST RETENTION FORCE

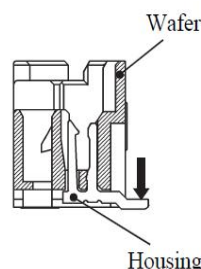
(1) Requirement: 0.3 kgf (min.)

(2) Test method: The end of a post shall be pushed in a perpendicular to wafer. The load to make the post start moving shall be measured.

Insertion and withdrawal speed: 25.4 mm/minute.

(3) Test results: N=10

Max.	Min.	Ave.
1.05kgf	1.25kgf	1.15kgf



PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 7/11

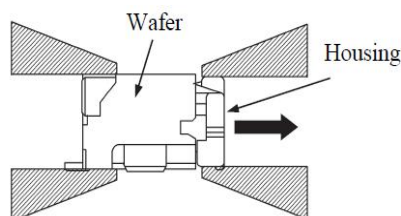
6.6 POST RETENTION FORCE

(1) Requirement: See items 6.2

(2) Test method: The end of a post shall be pushed in a perpendicular to wafer. The load to make the post start moving shall be measured.

Insertion and withdrawal speed: 25.4 mm/minute.

(3) Test results: See items 6.2



7. ELECTRICAL TEST:

7.1 Contact resistance

(1) Requirement: Initial : 20 mΩ (max.)

After environmental test : 40 m Ω (max.)

(2) Condition: Test current : 10 mA (DC)

Open voltage : 20mV (max.)

(3) Test result: See items 8.1 ~ 8.4

7.2 Insulation resistance

(1) Requirement: Initial : 500 MΩ (min.)

After humidity test : 300 MΩ (min.)

After thermal shock test : 300 MΩ (min.)

(2) Test method: DC 500V shall be applied between outer surface of housing and terminal and between adjacent terminals to measure insulation resistance.

(MIL-STD-202 , test method 302 , condition B)

(3) Test result: See items 8.2 & 8.5

7.3 Dielectric withstanding voltage

(1) Requirement: There shall be no breakdown nor flashover.

(2) Test method: Initially AC 500V (rms) and after humidity and thermal shock tests AC 300V (rms) shall be applied between outer surface of housing and terminal and between adjacent terminals for one minutes. (MIL-STD-202 , test method 301)

Test current : 1mA

(3) Test result: See items 8.2 & 8.5

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 8/11

8. ENVIRONMENT TEST:

8.1 Repeated Insertion/Withdrawal

(1) Requirement: Contact resistance shall be 40 milliohms (max.) after the test. Insulation

(2) Test method: Mated connector shall be mated up to 30 cycles repeatedly by the rate of 10 cycles per minute. After the test , contact resistance shall be measured.

(3) Test result:

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min.	Ave.
	8.41	8.1	8.24	17.48	17.22	17.32

N=10

8.2 Humidity

(1) Requirement: Contact resistance shall be 40 milliohms (max.) after the test. Insulation resistance shall be 300 megohms (min.) after the test. There shall be no breakdown nor flashover on dielectric withstanding voltage test.

(2) Test method: Mated connector shall be placed in a humidity chamber of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured. (MIL-STD-202 , test method 103 , condition A)

Temperature : 60 ±2 °C

Humidity : 90% ~ 95% (RH)

Period : 240 hours continuously

(3) Test results:

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min.	Ave.
	8.41	8.1	8.24	18.37	16.21	17.7

N=10

Test item	Housing-Terminal (MΩ)		Terminal-Terminal (MΩ)	
Insulation resistance	Initial	After test	Initial	After test
	500min	300min	500min	300min

N=10

Test item	Housing-Terminal		Terminal-Terminal	
D.W.V.	Initial	After test	Initial	After test
	Good	Good	Good	Good

N=10

(D.W.V. : Dielectric withstanding voltage)

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 9/11

8.3 Salt spray

- (1) Requirement: Contact resistance shall be 40 milliohms (max.) after the test.
- (2) Test method: Mated connector shall be subjected to salt spray test of the following conditions. After the test, specimen shall be washed with running water and dried naturally before the measurement of contact resistance.

Temperature : 35 ± 2 °C

Humidity : 90% ~ 95% (RH)

Period : 48 hours

(3) Test result:

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min.	Ave.
	8.41	8.1	8.24	16.32	12.36	14.3

N=10

8.4 Heat Resistance & Cold Resistance

- (1) Requirement: Contact resistance shall be 40 milliohms (max.) after the test.
- (2) Test method: Mated connector shall be placed in a heat oven & cold oven of the following conditions. After the test, contact resistance shall be measured.

Temperature : $+105 \pm 2$ °C

Period : 250 hours

Temperature : -40 ± 2 °C

Period : 250 hours

(3) Test result:

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min.	Ave.
	8.41	8.1	8.24	15.75	15.24	15.53

N=10

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES
PAGE : 10/1

8.5 Thermal shock

(1) Requirement: Contact resistance shall be 40 milliohms (max.) after the test. Insulation resistance shall be 500 megohms (min.) after the test. There shall be no breakdown nor flashover on dielectric withstanding voltage test.

(2) Test method: Mated connector shall be subjected to thermal shock test of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured.

1 cycle consists of:

-55±3 °C for 30 minutes

+85±2 °C for 30 minutes

Times of cycles: 25 cycles

(3) Test results:

Test item	Initial (mΩ)			After test (mΩ)			
	Max.	Min.	Ave.	Max.	Min.	Ave.	
Contact resistance	8.41	8.1	8.24	18.25	12.35	15.07	N=10

Test item	Housing-Terminal (MΩ)		Terminal-Terminal (MΩ)		
	Initial	After test	Initial	After test	
Insulation resistance	500min	300min	500min	300min	N=10

Test item	Housing-Terminal		Terminal-Terminal		
	Initial	After test	Initial	After test	
D.W.V.	Good	Good	Good	Good	N=10

(D.W.V. : Dielectric withstanding voltage)

8.6 Vibration

(1) Requirements: Contact resistance shall be 40 milliohms (max.) after the test. There shall be no current discontinuity longer than 1 microsecond during the test.

(2) Test method: Mated connector shall be mounted on a PCB and subjected to a vibration test of the following conditions. During the test , current continuity shall be checked. After the test , contact resistance shall be measured.

(MIL-STD-202 , test method 201)

PRODUCT SPECIFICATION

PRODUCT SERIES NAME: A1501-D SERIES

PAGE : 11/1

Frequency : 10~55~10 Hz/min.

Amplitude : 1.52 mm

Direction : 1. Axis of X, 2hours

2. Axis of Y, 2hours

3. Axis of Z, 2hours

(3) Test results:

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min.	Ave.
	8.41	8.1	8.24	18.32	13.56	15.16

N=10

Current discontinuity: There shall be no current discontinuity longer than 1 microsecond during the test.

8.7 Solderability

(1) Requirements: 95% of immersed area must show no voids.pin holes.

(2) Test method : Fluxed soldering section of shrouded header shall be dipped in solder of the following conditions.

Solder temperature : 245 ±3 °C

Immersion period : 3~5 seconds

(3) Test result: Good.

8.8 Resistance to soldering heat

(1) Requirements: There shall be no deformation nor damage which may affect the performance.

(2) Test method : Specimen shall be mounted on a PCB (inserted only) and subjected to resistance to soldering heat test of the following conditions.

Solder temperature : 260 ±5 °C

Immersion period :3~5 seconds

(3) Test result: Good.